

EH25 45

Series -RoHS Compliant (Pb-free) 5.0V 4 Pad 5mm x 7mm Ceramic SMD HCMOS/TTL High Frequency Oscillator Frequency Tolerance/Stability ±50ppm Maximum

### TS -10.240M

L Nominal Frequency 10.240MHz

Pin 1 Connection Tri-State (High Impedance)

Duty Cycle 50 ±10(%)

| Operating  | Temperature | Ran |
|------------|-------------|-----|
| 0°C to +70 | °C          |     |

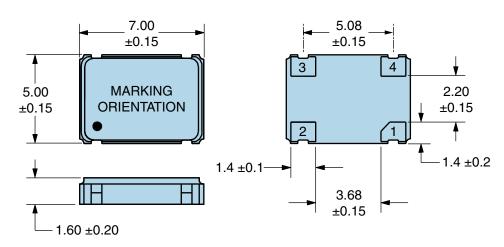
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| ELECTRICAL SPECIFICA                  |  |
|---------------------------------------|--|
| Nominal Frequency                     | 10.240MHz  |
| Frequency Tolerance/Stability         | ±50ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration) |
| Aging at 25°C                         | ±5ppm/year Maximum   |
| Operating Temperature Range           | 0°C to +70°C   |
| Supply Voltage                        | 5.0Vdc ±10%  |
| Input Current                         | 50mA Maximum (No Load)   |
| Output Voltage Logic High (Voh)       | 2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)  |
| Output Voltage Logic Low (Vol)        | 0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)  |
| Rise/Fall Time                        | 6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)   |
| Duty Cycle                            | 50 ±10(%) (Measured at 1.4Vdc with TTL Load; Measured at 50% of waveform with HCMOS Load)  |
| Load Drive Capability                 | 10TTL Load or 50pF HCMOS Load Maximum  |
| Output Logic Type                     | CMOS   |
| Pin 1 Connection                      | Tri-State (High Impedance)   |
| Tri-State Input Voltage (Vih and Vil) | +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.   |
| Absolute Clock Jitter                 | ±250pSec Maximum, ±100pSec Typical   |
| One Sigma Clock Period Jitter         | ±50pSec Maximum, ±30pSec Typical   |
| Start Up Time                         | 10mSec Maximum   |
| Storage Temperature Range             | -55°C to +125°C  |

#### **ENVIRONMENTAL & MECHANICAL SPECIFICATIONS**

| MIL-STD-883, Method 3015, Class 1, HBM: 1500V |
|---|
| MIL-STD-883, Method 1014, Condition A         |
| UL94-V0                                       |
| MIL-STD-883, Method 1014, Condition C         |
| MIL-STD-883, Method 2002, Condition B         |
| MIL-STD-883, Method 1004                      |
| J-STD-020, MSL 1                              |
| MIL-STD-202, Method 210, Condition K          |
| MIL-STD-202, Method 215                       |
| MIL-STD-883, Method 2003                      |
| MIL-STD-883, Method 1010, Condition B         |
| MIL-STD-883, Method 2007, Condition A         |
|   |

### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



|     | CORPORATION |
|-----|-------------|
| PIN | CONNECTION  |
| 1   | Tri-State   |
| 2   | Ground      |
| 0   | Outrait     |

|        | III-State           |
|--------|---------------------|
| 2      | Ground              |
| 3      | Output              |
| 4      | Supply Voltage      |
| LINE   | MARKING             |
|        |                     |
| 1      | ECLIPTEK            |
| 1<br>2 | ECLIPTEK<br>10.240M |

#### Suggested Solder Pad Layout

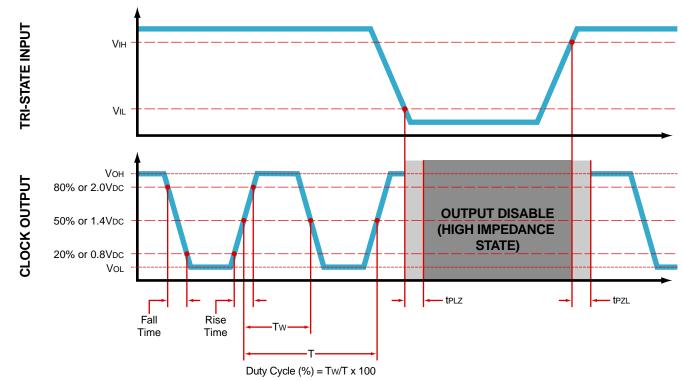
All Dimensions in Millimeters



All Tolerances are ±0.1

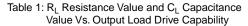


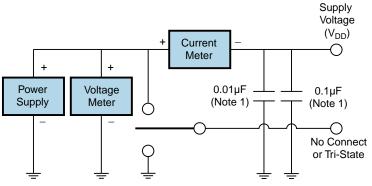
#### **OUTPUT WAVEFORM & TIMING DIAGRAM**

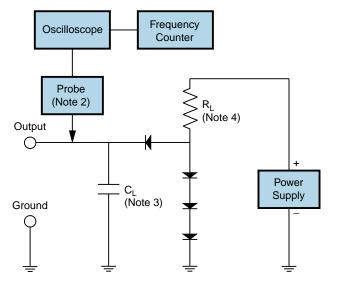


#### Test Circuit for TTL Output

| Output Load<br>Drive Capability | R <sub>L</sub> Value<br>(Ohms) | C <sub>L</sub> Value<br>(pF) |
|---------------------------------|--------------------------------|------------------------------|
| 10TTL                           | 390                            | 15                           |
| 5TTL                            | 780                            | 15                           |
| 2TTL                            | 1100                           | 6                            |
| 10LSTTL                         | 2000                           | 15                           |
| 1TTL                            | 2200                           | 3                            |







Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth

(>300MHz) passive probe is recommended.

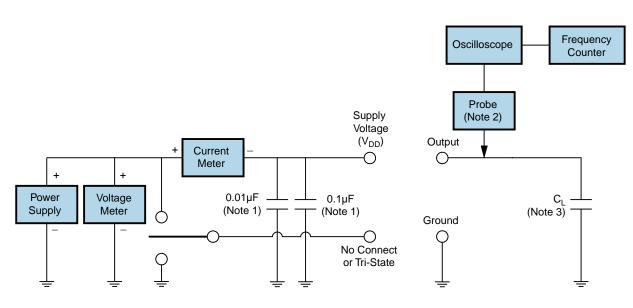
Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.

Note 4: Resistance value R<sub>L</sub> is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.

Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



### **Test Circuit for CMOS Output**



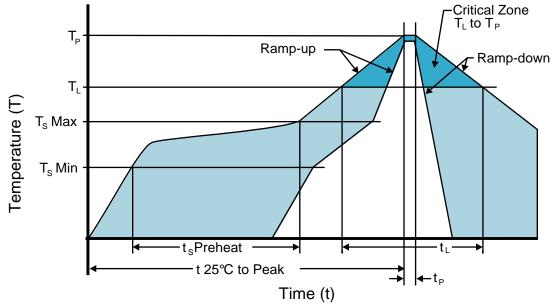
Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_1$  includes sum of all probe and fixture capacitance.

### **ECLIPTEK** CORPORATION

## **Recommended Solder Reflow Methods**



### **High Temperature Infrared/Convection**

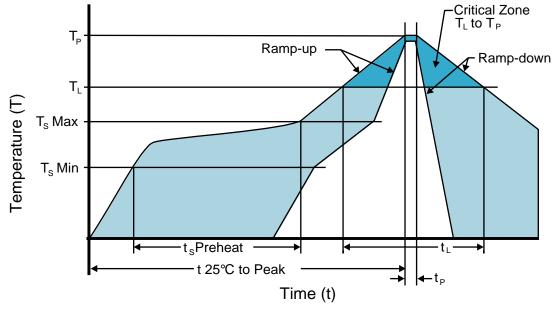
EH2545TS-10.240M

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)         | 3°C/second Maximum                                |
|---|---|
| Preheat   |   |
| - Temperature Minimum (T <sub>s</sub> MIN)                  | 150°C   |
| - Temperature Typical (T <sub>s</sub> TYP)                  | 175°C   |
| <ul> <li>Temperature Maximum (T<sub>s</sub> MAX)</li> </ul> | 200°C   |
| - Time (t <sub>s</sub> MIN)                                 | 60 - 180 Seconds                                  |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )            | 3°C/second Maximum                                |
| Time Maintained Above:                                      |   |
| - Temperature (T∟)  | 217°C   |
| - Time (t∟)   | 60 - 150 Seconds                                  |
| Peak Temperature (T <sub>P</sub> )                          | 260°C Maximum for 10 Seconds Maximum              |
| Target Peak Temperature (T <sub>P</sub> Target)             | 250°C +0/-5°C                                     |
| Time within 5°C of actual peak (t <sub>p</sub> )            | 20 - 40 seconds                                   |
| Ramp-down Rate  | 6°C/second Maximum                                |
| Time 25°C to Peak Temperature (t)                           | 8 minutes Maximum                                 |
| Moisture Sensitivity Level                                  | Level 1   |
| Additional Notes  | Temperatures shown are applied to body of device. |
|   |   |

### **ECLIPTEK** CORPORATION

## **Recommended Solder Reflow Methods**

EH2545TS-10.240M



### Low Temperature Infrared/Convection 240°C

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)         | 5°C/second Maximum                                     |
|---|--|
| Preheat   |  |
| - Temperature Minimum (T <sub>s</sub> MIN)                  | N/A  |
| <ul> <li>Temperature Typical (T<sub>s</sub> TYP)</li> </ul> | 150°C  |
| <ul> <li>Temperature Maximum (T<sub>s</sub> MAX)</li> </ul> | N/A  |
| - Time (t <sub>s</sub> MIN)                                 | 60 - 120 Seconds                                       |
| Ramp-up Rate (T⊾ to T <sub>P</sub> )                        | 5°C/second Maximum                                     |
| Time Maintained Above:                                      |  |
| - Temperature (T∟)  | 150°C  |
| - Time (t∟)   | 200 Seconds Maximum                                    |
| Peak Temperature (T <sub>P</sub> )                          | 240°C Maximum  |
| Target Peak Temperature (T <sub>P</sub> Target)             | 240°C Maximum 1 Time / 230°C Maximum 2 Times           |
| Time within 5°C of actual peak (t <sub>p</sub> )            | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| Ramp-down Rate  | 5°C/second Maximum                                     |
| Time 25°C to Peak Temperature (t)                           | N/A  |
| Moisture Sensitivity Level                                  | Level 1  |
| Additional Notes  | Temperatures shown are applied to body of device.      |
|   |  |

#### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)